

## MOS FIELD EFFECT TRANSISTOR

2SK3434

## SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

## **DESCRIPTION**

The 2SK3434 is N-channel MOS Field Effect Transistor designed for high current switching applications.

## **FEATURES**

• Super low on-state resistance:

 $R_{DS(on)1} = 20 \text{ m}\Omega$  MAX. (Vgs = 10 V, ID = 24 A)

- ★ RDS(on)2 = 31 m $\Omega$  MAX. (Vgs = 4.0 V, ID = 24 A)
  - Low Ciss: Ciss = 2100 pF TYP.
  - Built-in gate protection diode

## ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

	Drain to Source Voltage	Voss	60	V
	Gate to Source Voltage	Vgss	±20	V
	Drain Current (DC)	ID(DC)	±48	Α
	Drain Current (pulse) Note1	D(pulse)	±192	Α
*	Total Power Dissipation (Tc = 25°C)	Рт	56	W
	Total Power Dissipation (T <sub>A</sub> = 25°C)	Рт	1.5	W
	Channel Temperature	$T_ch$	150	°C
	Storage Temperature	$T_{stg}$	-55 to +150	°C
*	Single Avalanche Current Note2	las	28	Α
*	Single Avalanche Energy Note2	Eas	78	mJ

**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty cycle  $\leq$  1 %

**2.** Starting T<sub>ch</sub> = 25 °C, R<sub>G</sub> = 25  $\Omega$ , V<sub>GS</sub> = 20 V  $\rightarrow$  0 V

## THERMAL RESISTANCE

*	Channel to Case	Rth(ch-C)	2.23	°C/W
	Channel to Ambient	Rth(ch-A)	83.3	°C/W

## **ORDERING INFORMATION**

PART NUMBER	PACKAGE		
2SK3434	TO-220AB		
2SK3434-S	TO-262		
2SK3434-Z	TO-220SMD		

(TO-220AB)



(TO-262)



(TO-220SMD)



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Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

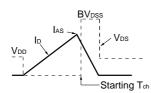


## **ELECTRICAL CHARACTERISTICS (TA = 25 °C)**

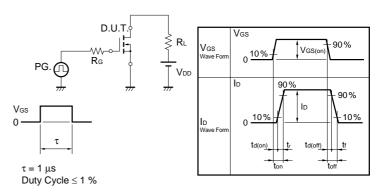
	CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
	Drain to Source On-state Resistance	RDS(on)1	Vgs = 10 V, ID = 24 A		16	20	mΩ
*		RDS(on)2	Vgs = 4.0 V, Ib = 24 A		22	31	mΩ
	Gate to Source Cut-off Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	1.5	2.0	2.5	V
*	Forward Transfer Admittance	yfs	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 24 A	13	27		S
	Drain Leakage Current	Inss	Vps = 60 V, Vgs = 0 V			10	μΑ
	Gate to Source Leakage Current	Igss	Vgs = ±20 V, Vps = 0 V			±10	μΑ
	Input Capacitance	Ciss	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz		2100		pF
*	Output Capacitance	Coss			340		pF
	Reverse Transfer Capacitance	Crss			170		pF
*	Turn-on Delay Time	t <sub>d(on)</sub>	ID = 24 A, VGS(on) = 10 V, VDD = 30 V,		40		ns
*	Rise Time	tr	R <sub>G</sub> = 10 Ω		400		ns
*	Turn-off Delay Time	t <sub>d(off)</sub>			120		ns
*	Fall Time	<b>t</b> f			160		ns
	Total Gate Charge	Q <sub>G</sub>	ID = 48 A , VDD = 48 V, VGS = 10 V		40		nC
	Gate to Source Charge	Qgs			7		nC
*	Gate to Drain Charge	Q <sub>GD</sub>			11		nC
	Body Diode Forward Voltage	V <sub>F(S-D)</sub>	IF = 48 A, VGS = 0 V		1.0		V
*	Reverse Recovery Time	trr	IF = 48 A, VGS = 0 V,		43		ns
*	Reverse Recovery Charge	Qrr	di/dt = 100 A/μs		61		nC

## **TEST CIRCUIT 1 AVALANCHE CAPABILITY**

# $\begin{array}{c|c} & D.U.T. \\ \hline R_G = 25 \Omega \\ \hline V_{GS} = 20 \rightarrow 0 V \end{array} \begin{array}{c} D.U.T. \\ \hline > 50 \Omega \\ \hline \end{array} \begin{array}{c} V_{DD} \\ \hline \end{array}$



## **TEST CIRCUIT 2 SWITCHING TIME**

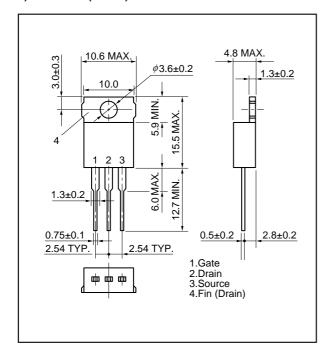


## **TEST CIRCUIT 3 GATE CHARGE**

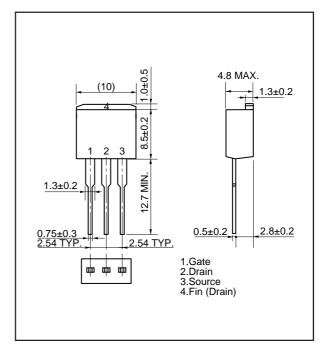


## PACKAGE DRAWINGS (Unit: mm)

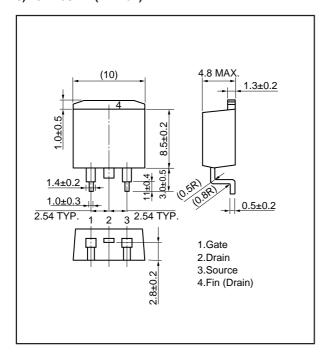
## 1) TO-220AB (MP-25)



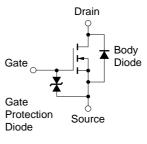
## 2) TO-262 (MP-25 Fin Cut)



## 3) TO-220SMD (MP-25Z)



## **EQUIVALENT CIRCUIT**



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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